

A single-atom electron spin qubit in silicon

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강병기

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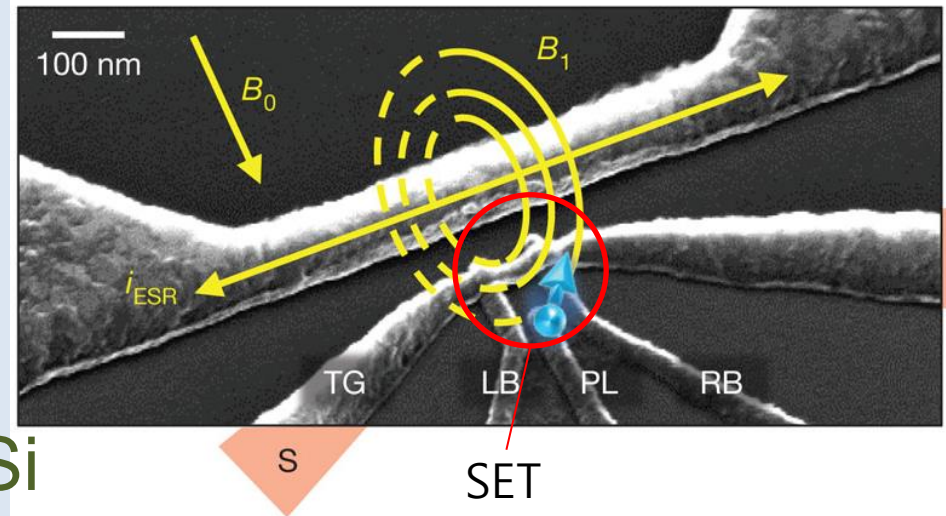
- Introduction: qubit
- Single qubit device
 - Single Electron Transistor(SET)
 - Performance property: ESR Pulsing scheme
- Coherent control: Rabi oscillations
- Coherence time: Measuring T_2
- Summary

Introduction

- Spin $\frac{1}{2}$: Candidate of qubit
- To realize
 - Fabrication
 - Initialization
 - Single qubit operation
 - Reading
 - Coherence
 - Double qubit operation: entanglement

Device

- Si substrate
- Al gate
- P ion implantation
 - It's like H atom in Si
- Single electron transistor (SET)
- Operating environment
 - $B_0 \sim 1 \text{ T}$
 - $B_1 \sim 30 \text{ GHz}, \sim 0.1 \text{ mT}$
 - 300 mK



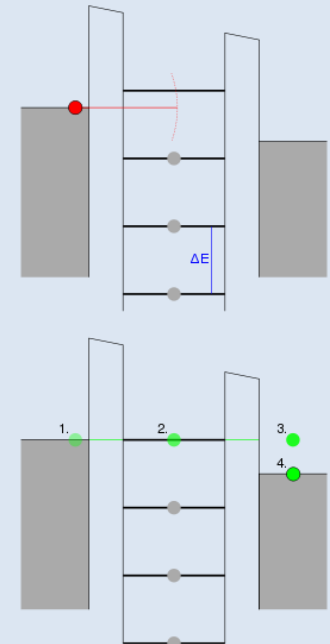
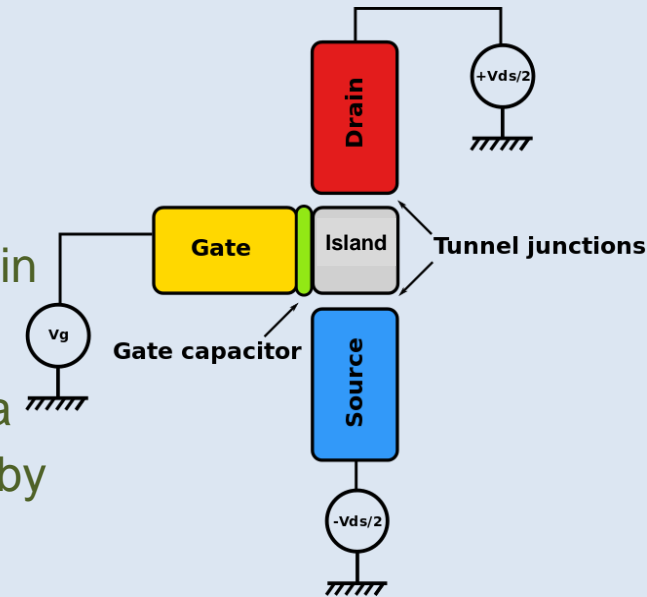
SET

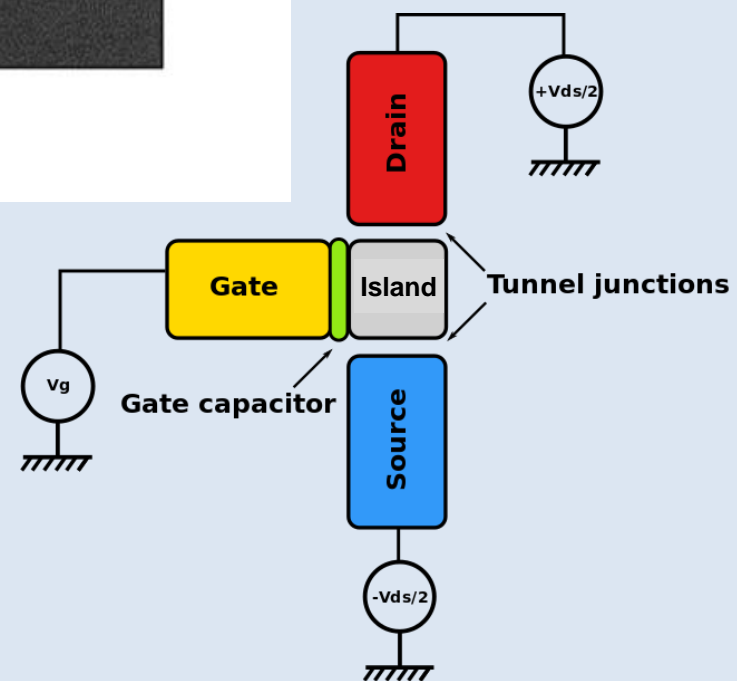
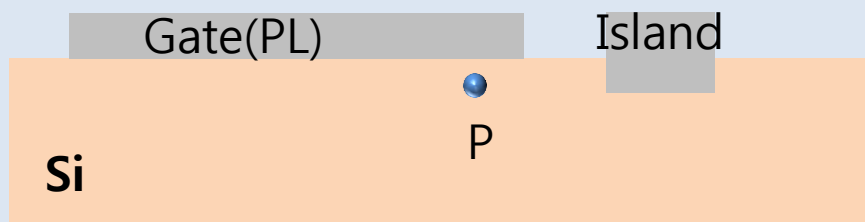
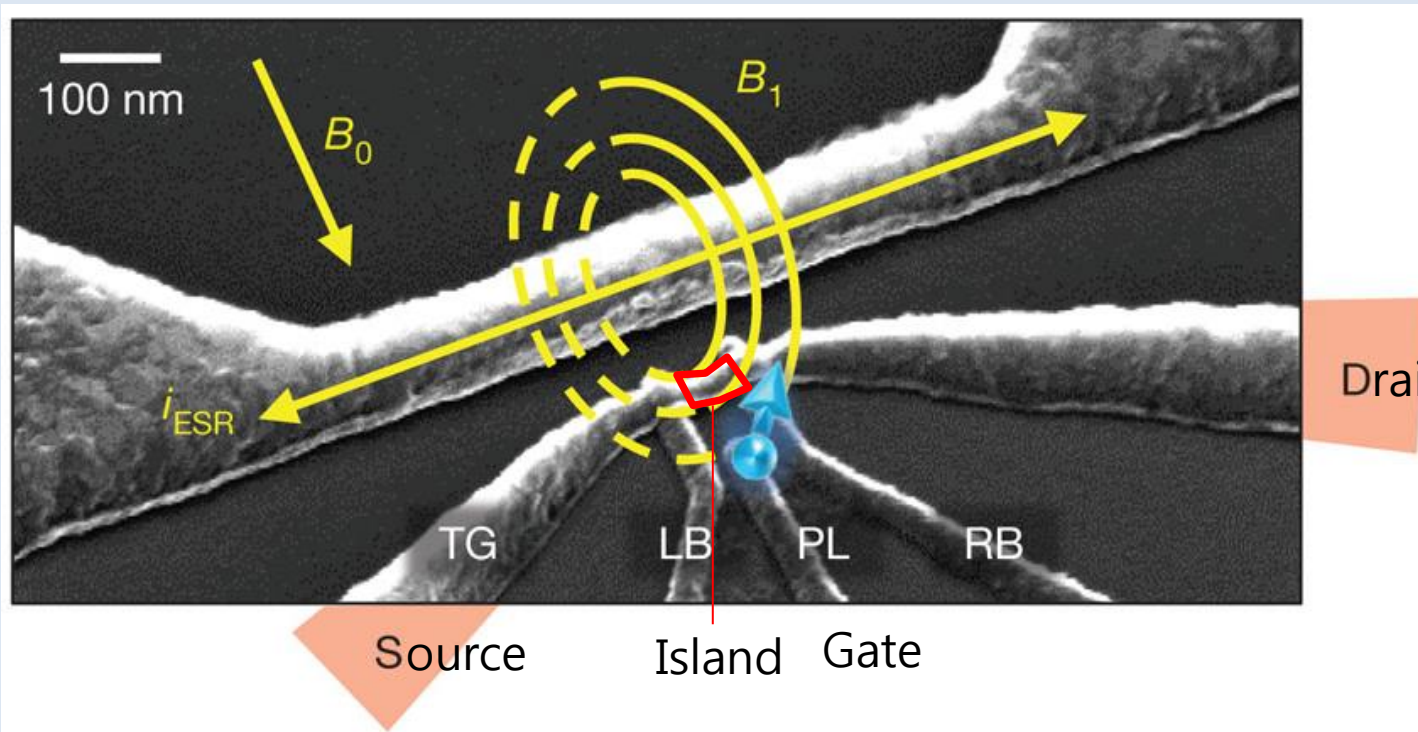
■ Property

- The SET is made by placing 2 tunnel junctions in series
- The 2 tunnel junction create what is known as a “Coulomb Island” that electrons can only enter by tunneling through one of the insulators.
- Since tunneling is a discrete process, the electric charge that flows through the tunnel junction flows in multiples of the charge of electrons e .

■ Coulomb blockade

- The effect in which electron can not pass through the island unless the energy in the system is equal to the Coulomb energy e^2/C .
- Coulomb blockade tries to alleviate any leak by current during the off state of the SET.





ESR Pulse scheme

- Donor P in Si

- $H = \gamma_e B_0 S_z - \gamma_n B_0 I_z + AS \cdot I$
- $\nu_{e1} \approx \gamma_e B_0 - A/2$
- $\nu_{e2} \approx \gamma_e B_0 + A/2$

- V_{PL} : donor level control

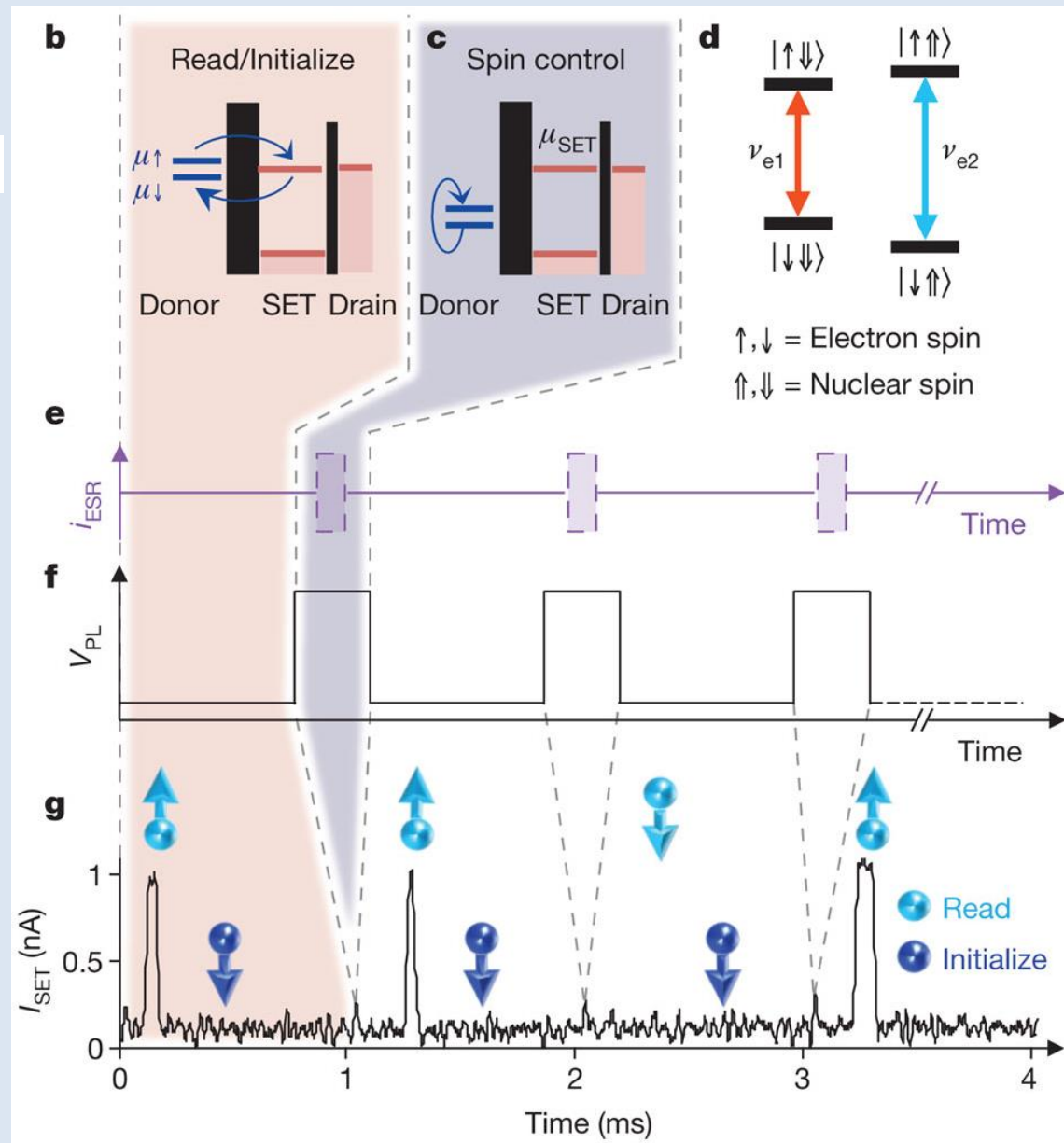
- Mode change

- i_{ESR} : B_1 ESR pulse

- Qubit control
- Freq.: ν_{e1} , ν_{e2}

- I_{SET} : drain current

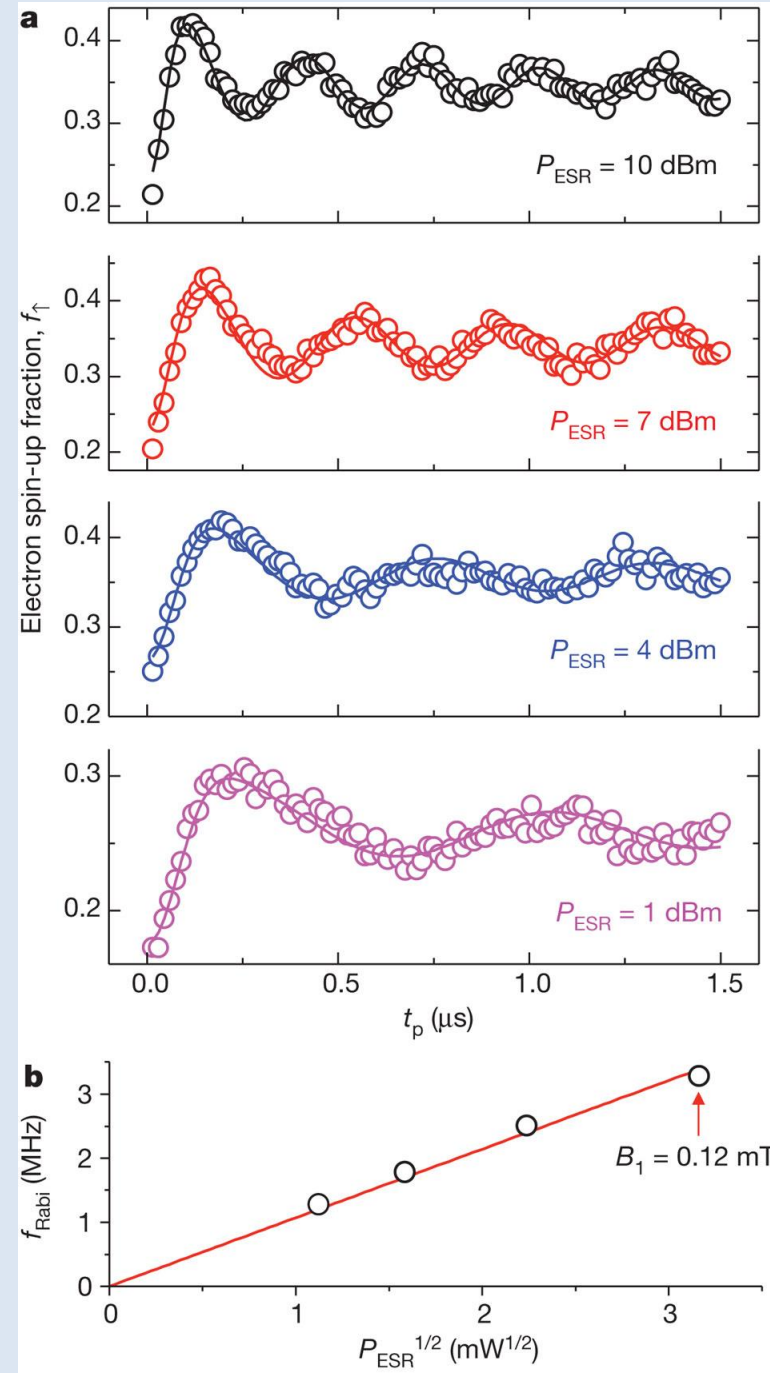
- Reading qubit state



Video clip

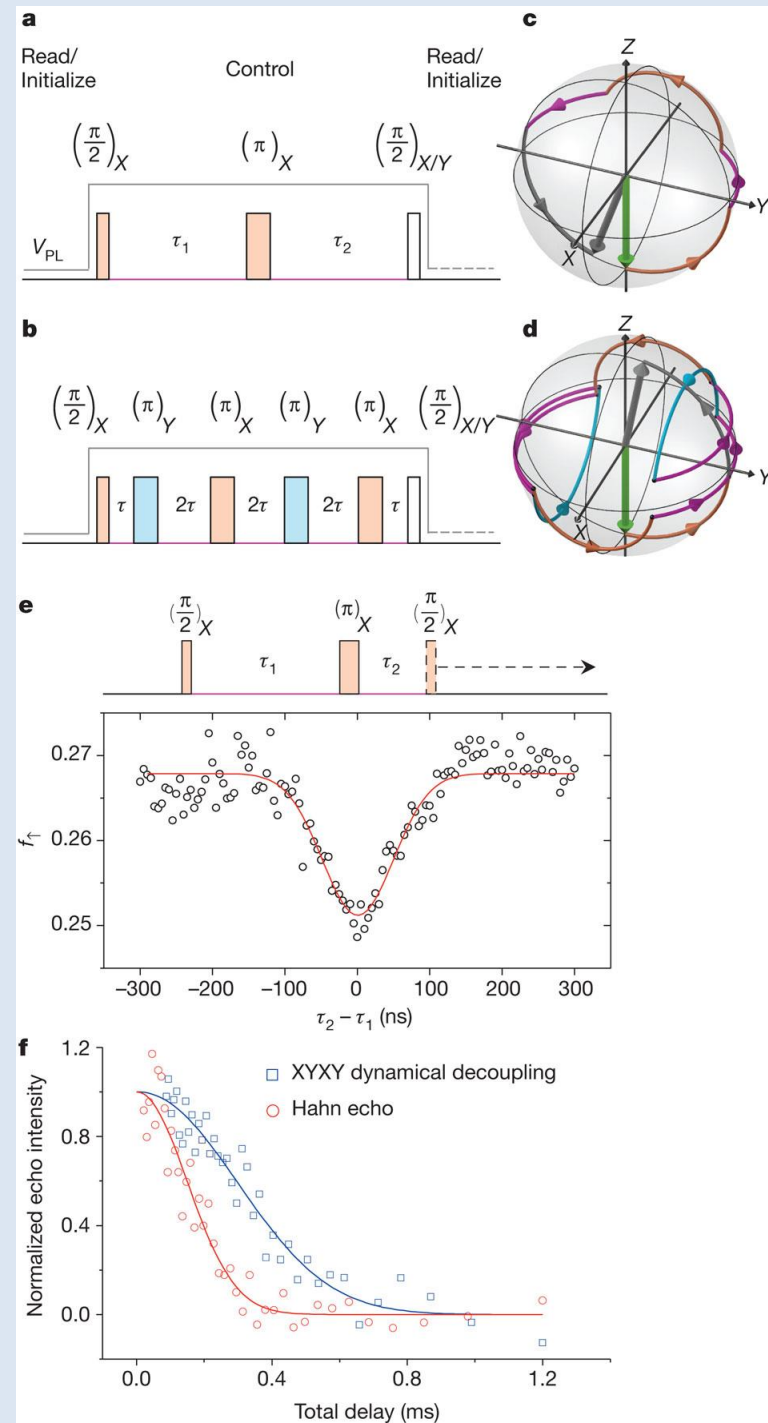
Rabi oscillation

- t_p : B_1 ESR pulse duration
- f_{\uparrow} : electron spin-up fraction
- P_{ESR} : power of ESR pulse
 - $P_{\text{ESR}}^{1/2} \propto \gamma_e B_1$
- f_{Rabi} : Rabi frequency $1/t_p$
 - $B_1 \cdot t_p = \text{constant}(\text{angle})$



Coherence time

- T_2 measuring
- Decoherence source
 - Diffusion of ^{29}Si
 - Noise in external field
 - Paramagnetic defects
 - Charge traps at interface
- Spin echo technique: **e**
 - $T_2^* \sim 55\text{ns}$
- Hahn echo : **a, c**
 - $T_2 = 206 \pm 12 \mu\text{s}$
- XYXY dynamic decoupling: **b, d**
 - $T_2 = 410 \pm 20 \mu\text{s}$



Summary

- Single-qubit realization with single atom electron with P ion in Si
 - Fabrication of SET
 - Operation with pulse-ESR
- Rabi oscillation: demonstration of coherence control
- Measuring T_2 : coherence time
 - Hahn echo
 - XYXY dynamic decoupling